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MOSFET – Power, **N-Channel**

100 V, 76 A, 13 m Ω

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- NVB Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ Unless otherwise specified)

Para	Parameter			Value	Unit
Drain-to-Source Voltage			V _{DSS}	100	V
Gate-to-Source Voltage	ge – Conti	nuous	V _{GS}	± 20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	76	Α
Current R _{θJC}	State	T _C = 100°C		54	
Power Dissipation $R_{\theta JC}$	Steady State	T _C = 25°C	P _D	188	W
Pulsed Drain Current	t _p	= 10 μs	I _{DM}	305	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	76	Α
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 Vdc, V_{GS} = 10 Vdc, $I_{L(pk)}$ = 57.7 A, L = 0.3 mH, R_{G} = 25 Ω)			E _{AS}	500	mJ
Lead Temperature for Purposes, 1/8" from C		Seconds	TL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	$R_{\theta JC}$	0.8	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	32	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

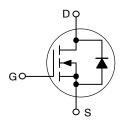


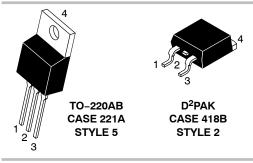
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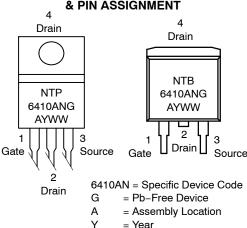
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX (Note 1)
100 V	13 mΩ @ 10 V	76 A

N-Channel





MARKING DIAGRAM & PIN ASSIGNMENT



ORDERING INFORMATION

WW = Work Week

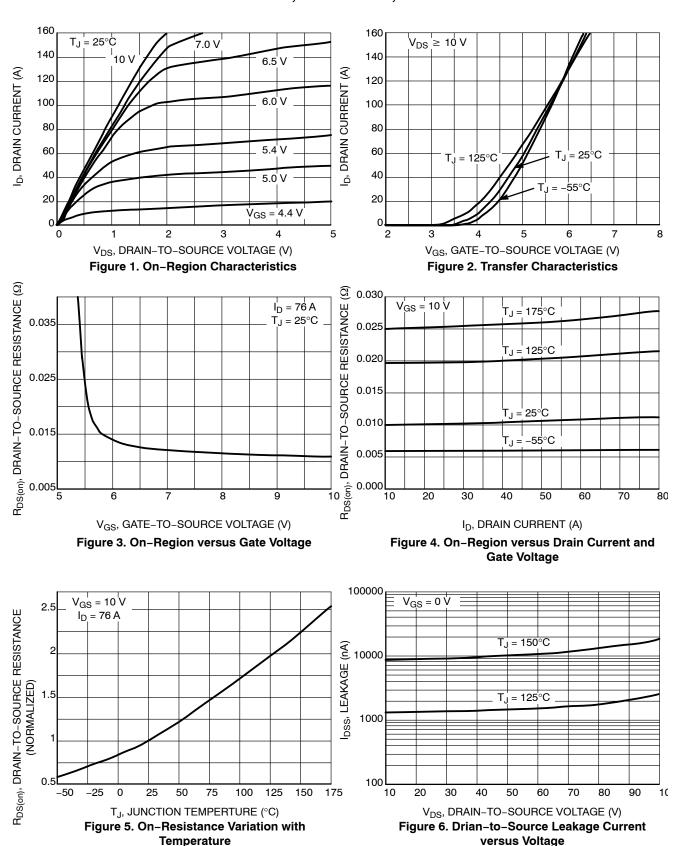
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

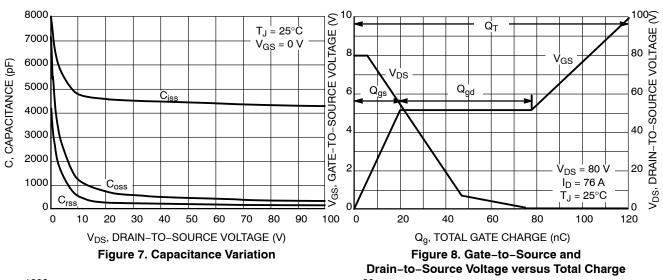
May, 2019 - Rev. 2

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ Unless otherwise specified)

Characteristics	Symbol	Test Co	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I	D = 250 μA	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				94		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		V _{DS} = 100 V	T _J = 150°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)						•	
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}$	I _D = 250 μA	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(th)} /T _J				9.0		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V	/, I _D = 76 A		11	13	mΩ
		V _{GS} = 10 V	/, I _D = 20 A		10	12	1
Forward Transconductance	9FS	V _{DS} = 5 V,	I _D = 20 A		40		S
CHARGES, CAPACITANCES & GATE RESIST.	ANCE				•		•
Input Capacitance	C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz			4500		pF
Output Capacitance	C _{oss}				650		_
Reverse Transfer Capacitance	C _{rss}				250		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 80 V, I _D = 76 A			120		nC
Threshold Gate Charge	Q _{G(TH)}				5.2		
Gate-to-Source Charge	Q _{GS}				20		
Gate-to-Drain Charge	Q_{GD}				57		1
Plateau Voltage	V_{GP}				5.1		V
Gate Resistance	R_{G}				2.4		Ω
SWITCHING CHARACTERISTICS, V _{GS} = 10 V	(Note 3)				•		•
Turn-On Delay Time	t _{d(on)}				17		ns
Rise Time	t _r	V _{G9} = 10 V.	V _{DD} = 80 V.		170		1
Turn-Off Delay Time	t _{d(off)}	V _{GS} = 10 V, I _D = 76 A, I	$R_{\rm G} = 6.2 \Omega$		120		1 '
Fall Time	t _f	_			190		
DRAIN-SOURCE DIODE CHARACTERISTICS					•		•
Forward Diode Voltage	V_{SD}		T _J = 25°C		1.0	1.3	V
		$I_S = 76 A$	T _J = 125°C		0.9		1
Reverse Recovery Time	t _{rr}				93		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, } I_S = 76 \text{ A,}$			69		1
Discharge Time	t _b	dl _{SD} /dt =	100 A/μs		24		1
Reverse Recovery Charge	Q _{RR}				300		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.





 $\begin{array}{c} 1000 \\ V_{DS} = 80 \text{ V} \\ I_{D} = 76 \text{ A} \\ V_{GS} = 10 \text{ V} \\ t_{r} \\ 100 \\ \hline \\ 100 \\ \hline \\ 100 \\ \hline \\ R_{G}, \text{ GATE RESISTANCE } (\Omega) \\ \end{array}$

Figure 9. Resistive Switching Time Variation versus Gate Resistance

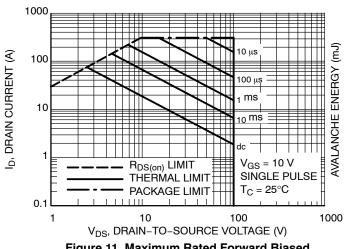


Figure 11. Maximum Rated Forward Biased Safe Opeating Area

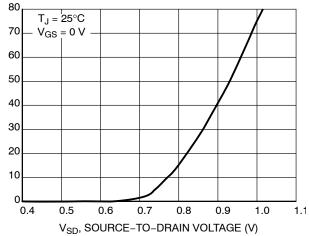


Figure 10. Diode Forward Voltage versus Current

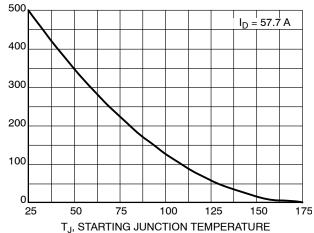


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

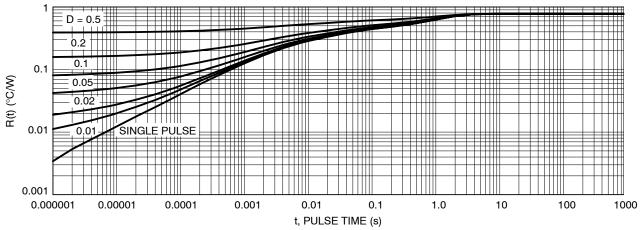
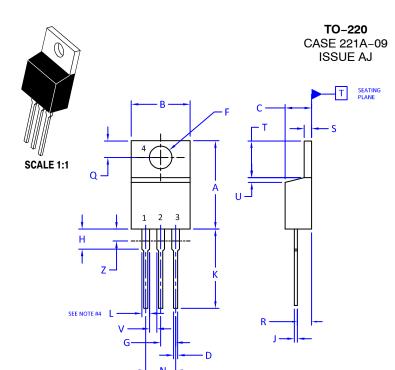


Figure 13. Thermal Response

ORDERING INFORMATION

Device	Package	Shipping [†]
NTB6410ANG	D ² PAK (Pb-Free)	50 Units / Rail
NTB6410ANT4G	D ² PAK (Pb-Free)	800 / Tape & Reel
NTP6410ANG	TO-220 (Pb-Free)	50 Units / Rail
NVB6410ANT4G	D ² PAK (Pb-Free)	800 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



DATE 05 NOV 2019

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

4. MAX WIDTH FOR F102 DEVICE = 1.35MM

	INCHES		MILLIMI	ETERS
DIM	MIN.	MAX.	MIN.	MAX.
Α	0.570	0.620	14.48	15.75
В	0.380	0.415	9.66	10.53
С	0.160	0.190	4.07	4.83
D	0.025	0.038	0.64	0.96
F	0.142	0.161	3.60	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.161	2.80	4.10
J	0.014	0.024	0.36	0.61
К	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.41
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045		1.15	
Z		0.080		2.04

STYLE 1:		STYLE 2:		STYLE 3:		STYLE 4:	
PIN 1.	BASE	PIN 1.	BASE	PIN 1.	CATHODE	PIN 1.	MAIN TERMINAL 1
2.	COLLECTOR	2.	EMITTER	2.	ANODE	2.	MAIN TERMINAL 2
3.	EMITTER	3.	COLLECTOR	3.	GATE	3.	GATE
4.	COLLECTOR	4.	EMITTER	4.	ANODE	4.	MAIN TERMINAL 2
STYLE 5:		STYLE 6:		STYLE 7:		STYLE 8:	
PIN 1.	GATE	PIN 1.	ANODE	PIN 1.	CATHODE	PIN 1.	CATHODE
2.	DRAIN	2.	CATHODE	2.	ANODE	2.	ANODE
3.	SOURCE	3.	ANODE	3.	CATHODE	3.	EXTERNAL TRIP/DELAY
4.	DRAIN	4.	CATHODE	4.	ANODE	4.	ANODE
STYLE 9:		STYLE 10:		STYLE 11:		STYLE 12:	:
PIN 1.	GATE	PIN 1.	GATE	PIN 1.	DRAIN	PIN 1.	MAIN TERMINAL 1
2.	COLLECTOR	2.	SOURCE	2.	SOURCE	2.	MAIN TERMINAL 2
3.	EMITTER	3.	DRAIN	3.	GATE	3.	GATE
4.	COLLECTOR	4.	SOURCE	4.	SOURCE	4.	NOT CONNECTED

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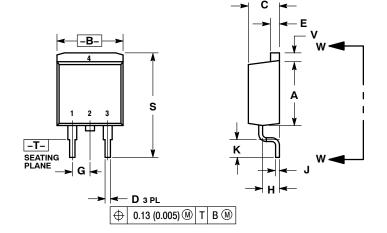
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D²PAK 3 CASE 418B-04 **ISSUE L**

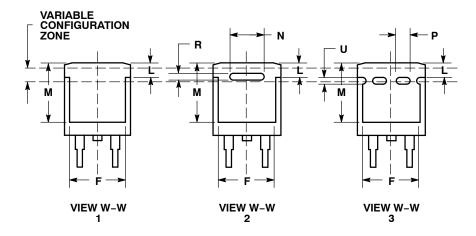
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SCALE 1:1



- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
- 3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INC	HES	IES MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.340	0.380	8.64	9.65	
В	0.380	0.405	9.65	10.29	
С	0.160	0.190	4.06	4.83	
D	0.020	0.035	0.51	0.89	
Е	0.045	0.055	1.14	1.40	
F	0.310	0.350	7.87	8.89	
G	0.100 BSC		2.54 BSC		
Н	0.080	0.110	2.03	2.79	
7	0.018	0.025	0.46	0.64	
K	0.090	0.110	2.29	2.79	
L	0.052	0.072	1.32	1.83	
М	0.280	0.320	7.11	8.13	
N	0.197	REF	5.00 REF		
Ь	0.079 REF		2.00 REF		
R	0.039	REF	0.99	REF	
S	0.575	0.625	14.60	15.88	
٧	0.045	0.055	1.14	1.40	



STYLE 1: PIN 1. BASE 2. COLLECTOR
3. EMITTER
4. COLLECTOR STYLE 2: PIN 1. GATE 2. DRAIN

3. SOURCE 4. DRAIN

STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE

STYLE 4:

PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR

STYLE 5: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. ANODE

STYLE 6:

PIN 1. NO CONNECT 2. CATHODE 3. ANODE 4. CATHODE

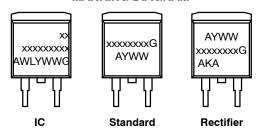
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GENERIC MARKING DIAGRAM*



xx = Specific Device Code A = Assembly Location

 WL
 = Wafer Lot

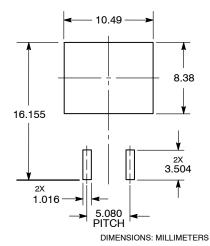
 Y
 = Year

 WW
 = Work Week

 G
 = Pb-Free Package

 AKA
 = Polarity Indicator

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " ■", may or may not be present.

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